Sea	rch	No	tes
Jea	<i>1</i>	, T C	,,,,,



Application/Control No.	Applicant(s)/Patent under Reexamination	<u> </u>
10/046,175	WATANABE, YOSHIAKI	•
Examiner	Art Unit	

Ryan F. Pitaro

2174

	SEAR	CHED	
Class	Subclass	Date	Examiner
Update	Search	11/21/2006	RFP
,			
-			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			:

SEAR (INCLUDING S	CH NOTES EARCH STRATEGY	·)
	DATE	EXMR
Update Search	11/21/2006	
•		